

# MT4600

## Dual N & P-Channel PowerTrench<sup>®</sup> MOSFET

### Features

- N-Channel  
30V/5A,  
 $R_{DS(ON)} = 28m\Omega$  (max.) @  $V_{GS} = 4.5V$   
 $R_{DS(ON)} = 38m\Omega$  (max.) @  $V_{GS} = 2.5V$
- P-Channel  
-30V/-4.6A,  
 $R_{DS(ON)} = 63m\Omega$  (max.) @  $V_{GS} = -4.5V$   
 $R_{DS(ON)} = 85m\Omega$  (max.) @  $V_{GS} = -2.5V$

### General Description

These dual N and P-Channel enhancement mode power field effect transistors are produced using MOS-TECH Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

### Applications

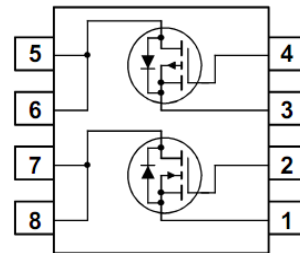
- DC-DC primary bridge
- DC-DC Synchronous rectification
- Hot swap
- Fan drive



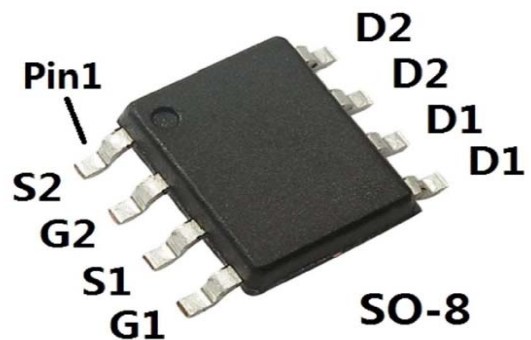
**MT Semiconductor<sup>®</sup>**

<http://www.mtsemi.com>

### Simplified Schematic



### MARKING DIAGRAM



### Absolute Maximum Ratings $T_A = 25^\circ C$ unless otherwise noted

Symbol	Parameter	N-CH	P-CH	Units
V <sub>DSS</sub>	Drain-Source Voltage	30	-30	V
V <sub>GSS</sub>	Gate-Source Voltage	±12	±12	V
I <sub>D</sub>	Drain Current   - Continuous			

### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	78	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	40	$^\circ C/W$

### Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
MT4600	MT4600	13"	12mm	2500 units

**Electrical Characteristics** $T_A = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
<b>Off Characteristics</b>							
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ $V_{GS} = 0\text{ V}, I_D = -250\text{ }\mu\text{A}$	N-CH P-CH	30 -30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$ $I_D = -250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$	N-CH P-CH		23 -21		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}$ $V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}$	N-CH P-CH			1 -1	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage	$V_{GS} = \pm 12\text{ V}, V_{DS} = 0\text{ V}$ $V_{GS} = \pm 12\text{ V}, V_{DS} = 0\text{ V}$	N-CH P-CH			$\pm 100$ $\pm 100$	nA

**On Characteristics** (Note 2)

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ $V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$	N-CH P-CH	0.8 -0.8	-	1.5 -2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$ $I_D = -250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$	N-CH P-CH		-4 4		mV/ $^\circ\text{C}$
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 5\text{ A}$ $V_{GS} = 4.5\text{ V}, I_D = 4\text{ A}$ $V_{GS} = 2.5\text{ V}, I_D = 3\text{ A}$ $V_{GS} = -10\text{ V}, I_D = -4\text{ A}$ $V_{GS} = -4.5\text{ V}, I_D = -3\text{ A}$ $V_{GS} = -2.5\text{ V}, I_D = -1\text{ A}$	N-CH P-CH		22 25 35 53 60 80	25 28 38 56 63 85	m $\Omega$
$I_{D(on)}$	On-State Drain Current	$V_{GS} = 10\text{ V}, V_{DS} = 5\text{ V}$ $V_{GS} = -10\text{ V}, V_{DS} = -5\text{ V}$	N-CH P-CH	20 -18			A
$g_{FS}$	Forward Transconductance	$V_{DS} = 15\text{ V}, I_D = 5\text{ A}$ $V_{DS} = -10\text{ V}, I_D = -3\text{ A}$	N-CH P-CH		18 16		S

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	N-CH $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}$ , $f = 1.0\text{ MHz}$	N-CH P-CH		830 1540		pF
$C_{oss}$	Output Capacitance	P-CH	N-CH P-CH		185 400		pF
$C_{rss}$	Reverse Transfer Capacitance	$V_{DS} = -15\text{ V}, V_{GS} = 0\text{ V}$ , $f = 1.0\text{ MHz}$	N-CH P-CH		80 170		pF

**Electrical Characteristics (continued)** $T_A = 25^\circ\text{C}$  unless otherwise noted

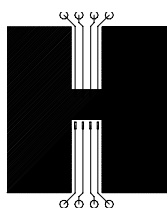
Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
<b>Switching Characteristics</b> (Note 2)							
$t_{d(on)}$	Turn-On Delay Time	N-CH $V_{DS} = 15\text{ V}, I_D = 1\text{ A}$ , $V_{GS} = 10\text{ V}, R_{GEN} = 6\text{ }\Omega$	N-CH P-CH		6 13	12 24	ns
$t_r$	Turn-On Rise Time		N-CH P-CH		10 22	18 35	ns
$t_{d(off)}$	Turn-Off Delay Time	P-CH $V_{DS} = -15\text{ V}, I_D = -1\text{ A}$ , $V_{GS} = -10\text{ V}, R_{GEN} = 6\text{ }\Omega$	N-CH P-CH		18 47	29 75	ns
$t_f$	Turn-Off Fall Time		N-CH P-CH		5 18	12 30	ns
$Q_g$	Total Gate Charge	N-CH $V_{DS} = 15\text{ V}, I_D = 2.5\text{ A}, V_{GS} = 5\text{ V}$	N-CH P-CH		9 15	13 20	nC
$Q_{gs}$	Gate-Source Charge	P-CH	N-CH P-CH		2.8 4		nC
$Q_{gd}$	Gate-Drain Charge	$V_{DS} = -10\text{ V}, I_D = -1\text{ A}, V_{GS} = -5\text{ V}$	N-CH P-CH		3.1 5		nC

### Drain-Source Diode Characteristics and Maximum Ratings

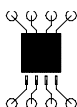
$I_S$	Maximum Continuous Drain-Source Diode Forward Current	N-CH P-CH			1.3 -1.3	A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 1.3\text{ A}$ (Note 2) $V_{GS} = 0\text{ V}, I_S = -1.3\text{ A}$ (Note 2)	N-CH P-CH	0.82 -0.85		V

#### Notes:

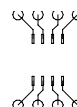
1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 78°C/W when mounted on a 0.5 in<sup>2</sup> pad of 2 oz copper



b) 125°C/W when mounted on a .02 in<sup>2</sup> pad of 2 oz copper



c) 135°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

## Typical Characteristics:N-CH

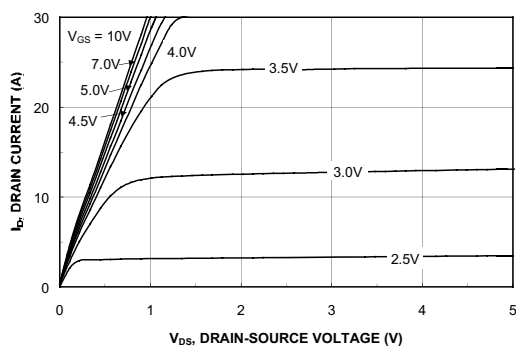


Figure 1. On-Region Characteristics.

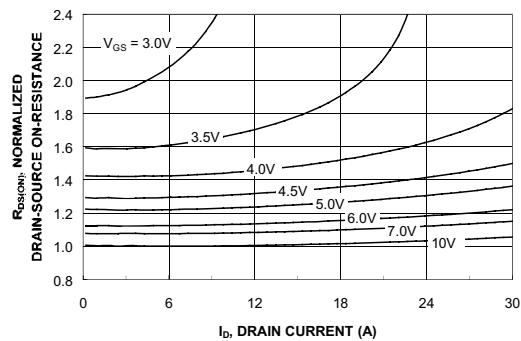


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

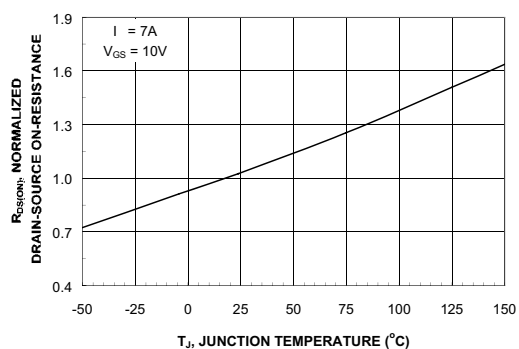


Figure 3. On-Resistance Variation with Temperature.

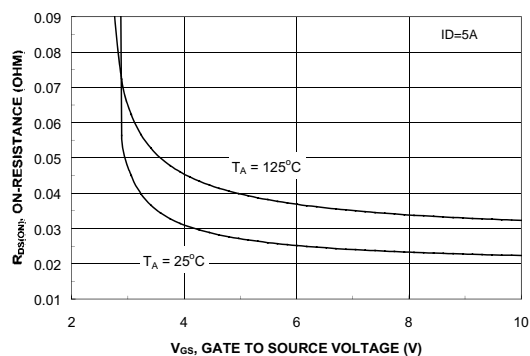


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

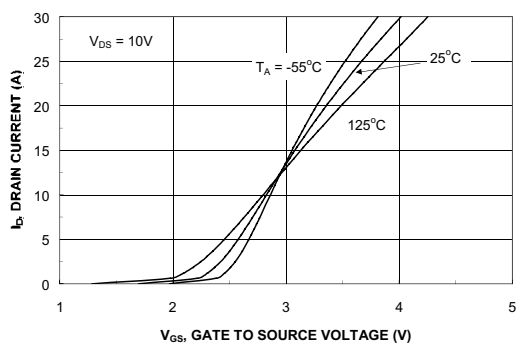


Figure 5. Transfer Characteristics.

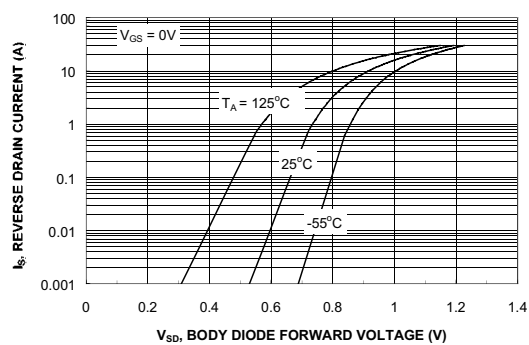


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## Typical Characteristics:N-CH

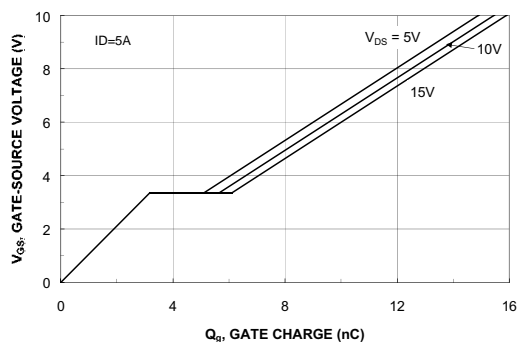


Figure 7. Gate Charge Characteristics.

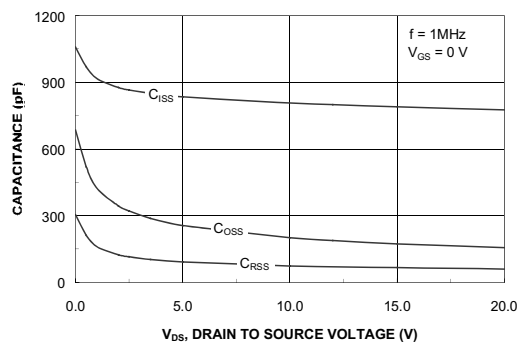


Figure 8. Capacitance Characteristics.

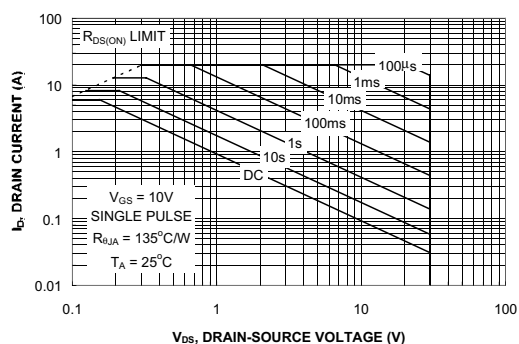


Figure 9. Maximum Safe Operating Area.

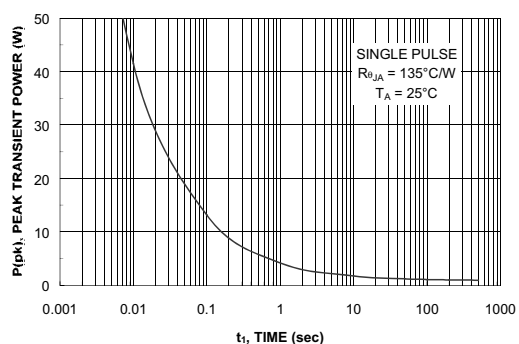


Figure 10. Single Pulse Maximum Power Dissipation.

## Typical Characteristics:P-CH

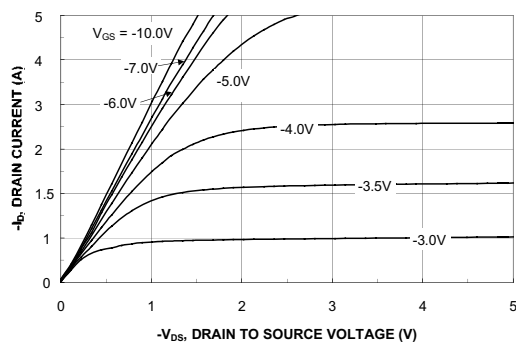


Figure 11. On-Region Characteristics.

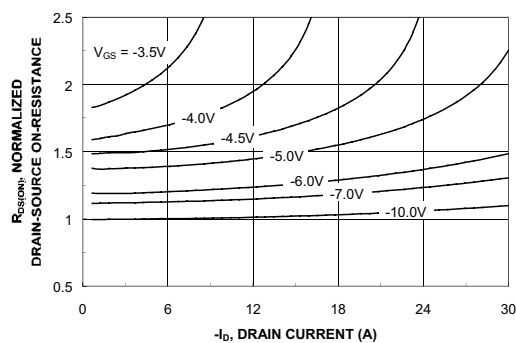


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

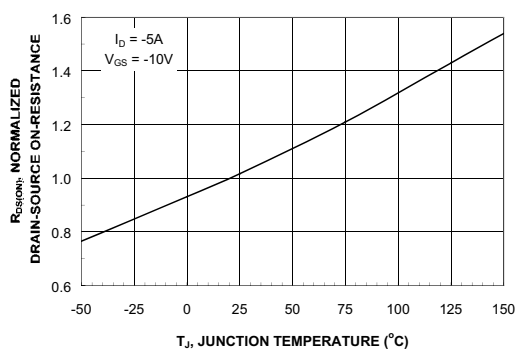


Figure 13. On-Resistance Variation with Temperature.

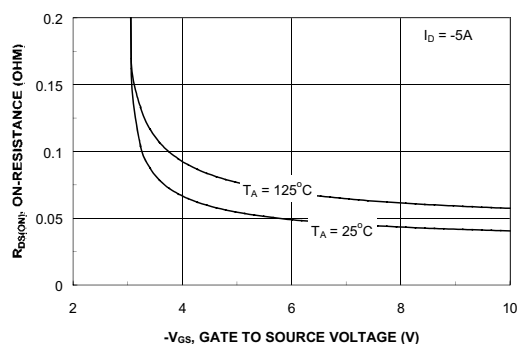


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

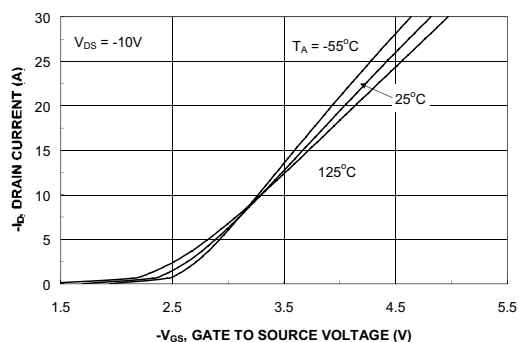


Figure 15. Transfer Characteristics.

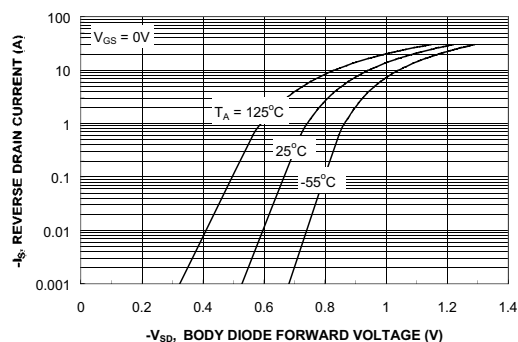


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

## Typical Characteristics:P-CH

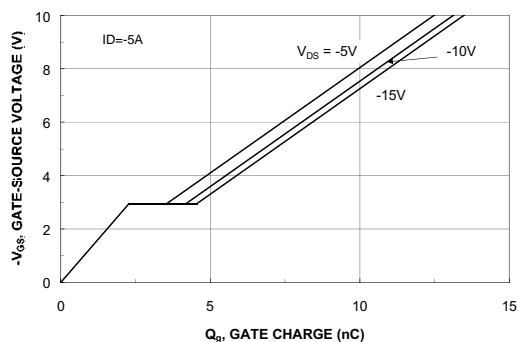


Figure 17. Gate Charge Characteristics.

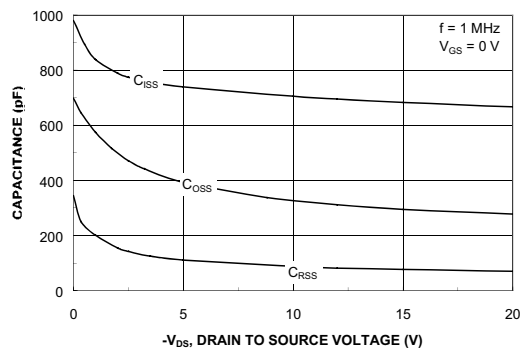


Figure 18. Capacitance Characteristics.

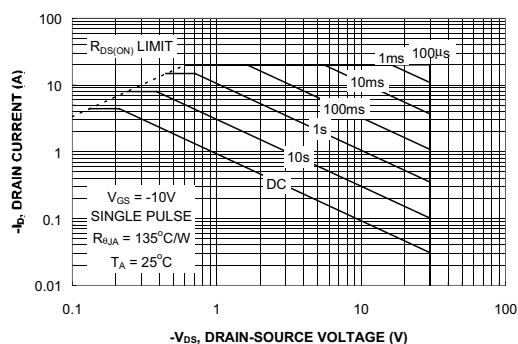


Figure 19. Maximum Safe Operating Area.

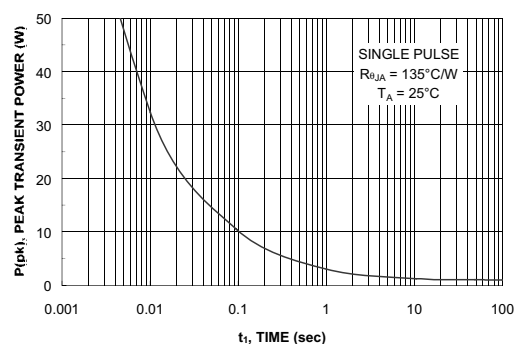


Figure 20. Single Pulse Maximum Power Dissipation.

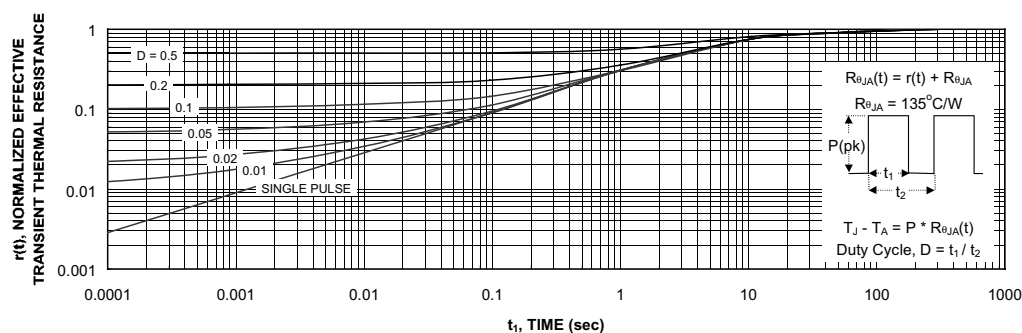
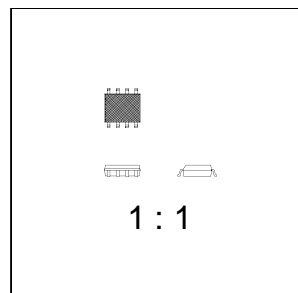
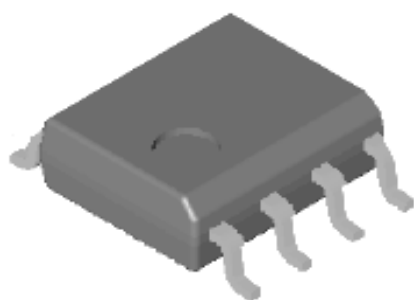


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c.  
Transient thermal response will change depending on the circuit board design.

## SO-8 Package Dimensions

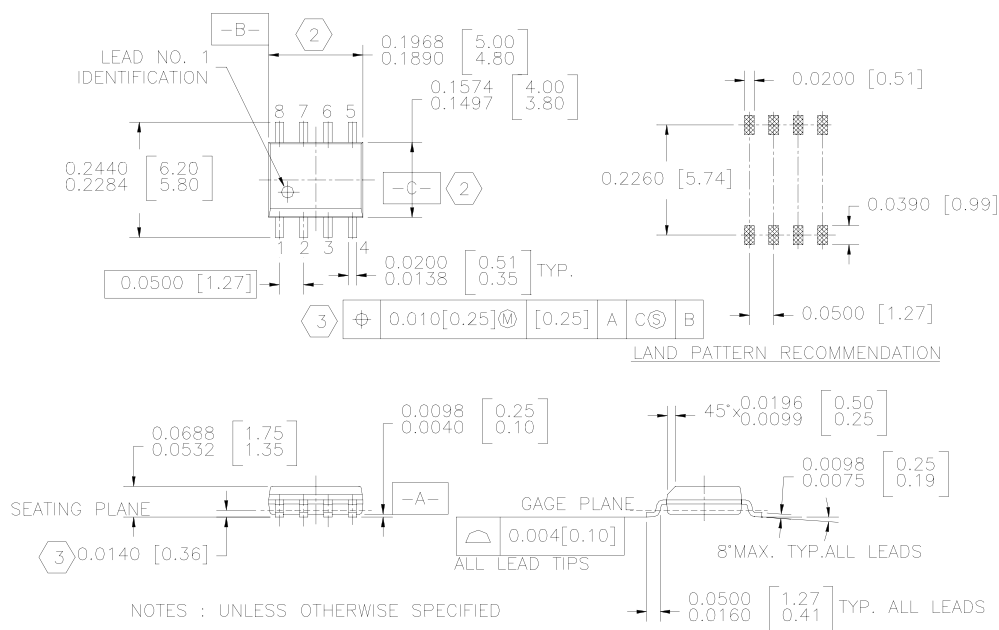
### SO-8 (PKG Code S1)



Scale 1:1 on letter size paper

Dimensions shown below are in:  
inches [millimeters]

Part Weight per unit (gram): 0.0774



NOTES : UNLESS OTHERWISE SPECIFIED

1. STANDARD LEAD FINISH:  
200 MICROINCHES / 5.08 MICRONS MINIMUM  
LEAD / TIN (SOLDER) ON COPPER.

SO 0.150 WIDE 8 LEADS

2. THESE DIMENSIONS DO NOT INCLUDE MOLD FLASH

3. MAXIMUM LEAD 0.024 [0.609]



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### Keep safety first in your circuit designs!

1. MOS-TECH Semiconductor Corp. puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage.  
Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of nonflammable material or (iii) prevention against any malfunction or mishap.